

FML20N50ES

FUJI POWER MOSFET

Super FAP-E³ series

N-CHANNEL SILICON POWER MOSFET

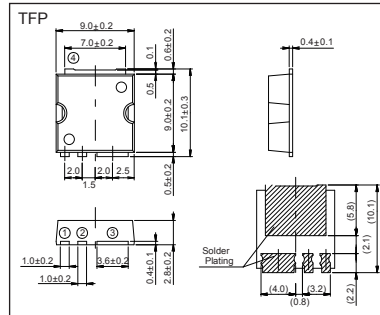
■ Features

Maintains both low power loss and low noise
Lower $R_{DS(on)}$ characteristic
More controllable switching dv/dt by gate resistance
Smaller V_{GS} ringing waveform during switching
Narrow band of the gate threshold voltage ($4.2 \pm 0.5V$)
High avalanche durability

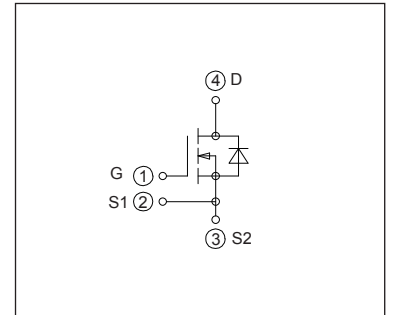
■ Applications

Switching regulators
UPS (Uninterruptible Power Supply)
DC-DC converters

■ Outline Drawings [mm]



■ Equivalent circuit schematic



■ Maximum Ratings and Characteristics

● Absolute Maximum Ratings at $T_c=25^\circ\text{C}$ (unless otherwise specified)

| Description | Symbol | Characteristics | Unit | Remarks |
|---|-----------|-----------------|-------------------|-------------------------------------|
| Drain-Source Voltage | V_{DS} | 500 | V | |
| | V_{DSX} | 500 | V | $V_{GS} = -30V$ |
| Continuous Drain Current | I_D | ± 20 | A | |
| Pulsed Drain Current | I_{DP} | ± 80 | A | |
| Gate-Source Voltage | V_{GS} | ± 30 | V | |
| Repetitive and Non-Repetitive Maximum Avalanche Current | I_{AR} | 20 | A | Note*1 |
| Non-Repetitive Maximum Avalanche Energy | E_{AS} | 582.5 | mJ | Note*2 |
| Repetitive Maximum Avalanche Energy | E_{AR} | 9.5 | mJ | Note*3 |
| Peak Diode Recovery dV/dt | dV/dt | 4.6 | kV/ μs | Note*4 |
| Peak Diode Recovery $-di/dt$ | $-di/dt$ | 100 | A/ μs | Note*5 |
| Maximum Power Dissipation | P_D | 2.16 | W | $T_a=25^\circ\text{C}$ |
| | | 95 | | $T_c=25^\circ\text{C}$ |
| Operating and Storage Temperature range | T_{ch} | 150 | $^\circ\text{C}$ | |
| | T_{stg} | -55 to + 150 | $^\circ\text{C}$ | |
| Isolation Voltage | V_{ISO} | 2 | kVrms | $t = 60\text{sec}, f = 60\text{Hz}$ |

● Electrical Characteristics at $T_c=25^\circ\text{C}$ (unless otherwise specified)

| Description | Symbol | Conditions | min. | typ. | max. | Unit |
|----------------------------------|--------------|--|------|------|-------|---------------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $I_D=250\mu\text{A}, V_{GS}=0V$ | 500 | - | - | V |
| Gate Threshold Voltage | $V_{GS(th)}$ | $I_D=250\mu\text{A}, V_{DS}=V_{GS}$ | 3.7 | 4.2 | 4.7 | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=500V, V_{GS}=0V$ | - | - | 25 | μA |
| | | $V_{DS}=400V, V_{GS}=0V$ | - | - | 250 | |
| Gate-Source Leakage Current | I_{GSS} | $V_{GS}=\pm 30V, V_{DS}=0V$ | - | 10 | 100 | nA |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $I_D=10A, V_{GS}=10V$ | - | 0.27 | 0.31 | Ω |
| Forward Transconductance | g_{fs} | $I_D=10A, V_{DS}=25V$ | 5 | 10 | - | S |
| Input Capacitance | C_{iss} | $V_{DS}=25V$ | - | 2100 | 3150 | pF |
| Output Capacitance | C_{oss} | $V_{GS}=0V$ | - | 250 | 375 | |
| Reverse Transfer Capacitance | C_{rss} | $f=1\text{MHz}$ | - | 15 | 22.5 | |
| Turn-On Time | $t_{d(on)}$ | $V_{cc}=300V$ | - | 40 | 60 | ns |
| | t_r | $V_{GS}=10V$ | - | 38 | 57 | |
| Turn-Off Time | $t_{d(off)}$ | $I_D=10A$ | - | 85 | 127.5 | |
| | t_f | $R_{GS}=15\Omega$ | - | 17 | 25.5 | |
| Total Gate Charge | Q_G | $V_{cc}=250V$ | - | 57 | 85.5 | nC |
| Gate-Source Charge | Q_{GS} | $I_D=20A$ | - | 21 | 31.5 | |
| Gate-Drain Charge | Q_{GD} | $V_{GS}=10V$ | - | 21 | 31.5 | |
| Gate-Drain Crossover Charge | Q_{SW} | | - | 10 | 15 | |
| Avalanche Capability | I_{AV} | $L=1.07\text{mH}, T_{ch}=25^\circ\text{C}$ | 20 | - | - | A |
| Diode Forward On-Voltage | V_{SD} | $I_F=20A, V_{GS}=0V, T_{ch}=25^\circ\text{C}$ | - | 0.90 | 1.35 | V |
| Reverse Recovery Time | t_{rr} | $I_F=20A, V_{GS}=0V$ | - | 0.5 | - | μs |
| Reverse Recovery Charge | Q_{rr} | $-di/dt=100A/\mu\text{s}, T_{ch}=25^\circ\text{C}$ | - | 7.0 | - | μC |

● Thermal Characteristics

| Description | Symbol | Test Conditions | min. | typ. | max. | Unit |
|--------------------|----------------|--------------------|------|------|-------|---------------------------|
| Thermal resistance | $R_{th(ch-c)}$ | Channel to Case | | | 1.320 | $^\circ\text{C}/\text{W}$ |
| | $R_{th(ch-a)}$ | Channel to Ambient | | | 58.0 | $^\circ\text{C}/\text{W}$ |

Note *1 : $T_{ch} \leq 150^\circ\text{C}$.

Note *2 : Stating $T_{ch}=25^\circ\text{C}$, $I_{AS}=8A$, $L=16.7\text{mH}$, $V_{CC}=50V$, $R_G=50\Omega$.

E_{AS} limited by maximum channel temperature and avalanche current.

See to 'Avalanche Energy' graph.

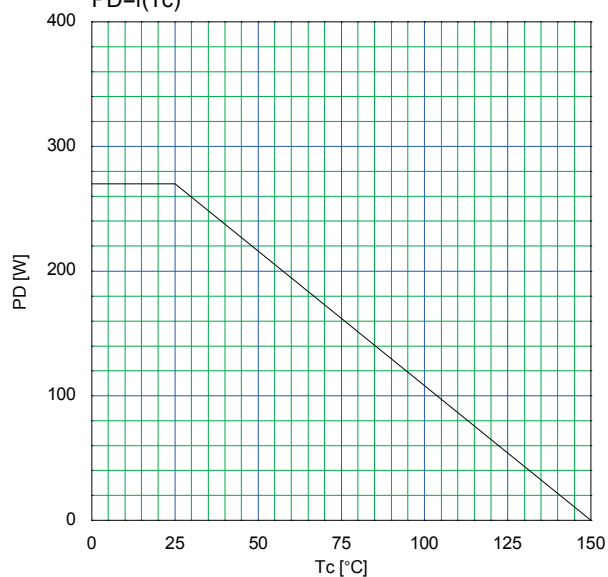
Note *3 : Repetitive rating : Pulse width limited by maximum channel temperature.

See to the 'Transient Thermal Impedance' graph.

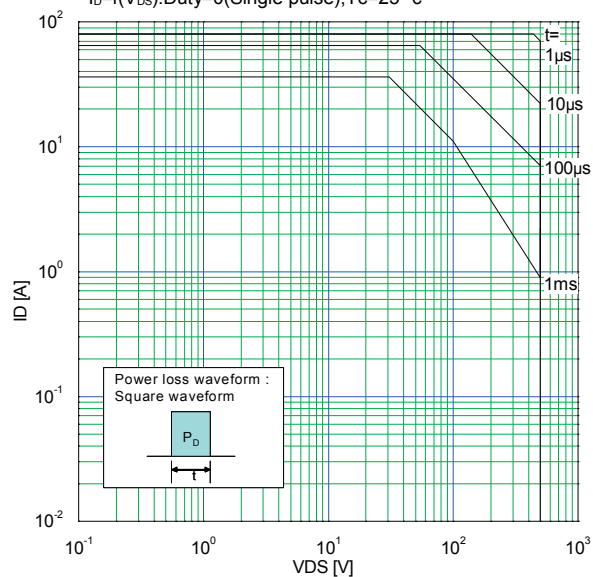
Note *4 : $I_F \leq I_D$, $-di/dt=100A/\mu\text{s}$, $V_{CC} \leq BV_{DSS}$, $T_{ch} \leq 150^\circ\text{C}$.

Note *5 : $I_F \leq I_D$, $dv/dt=4.6kV/\mu\text{s}$, $V_{CC} \leq BV_{DSS}$, $T_{ch} \leq 150^\circ\text{C}$.

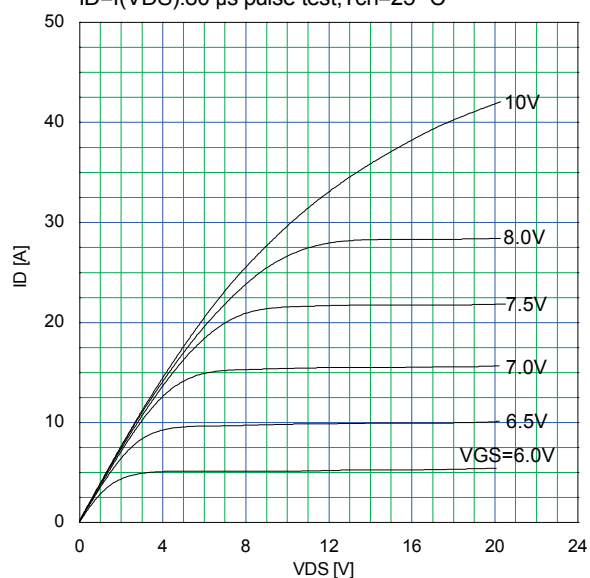
Allowable Power Dissipation
 $P_D = f(T_c)$



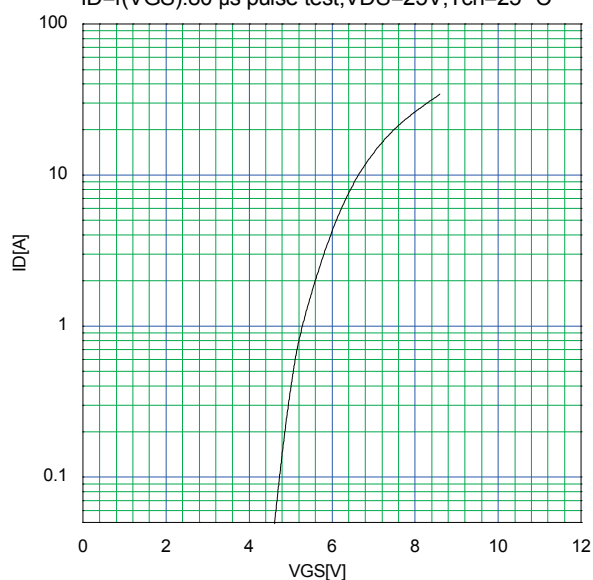
Safe Operating Area
 $I_D = f(V_{DS})$: Duty=0 (Single pulse), $T_c = 25$ °C



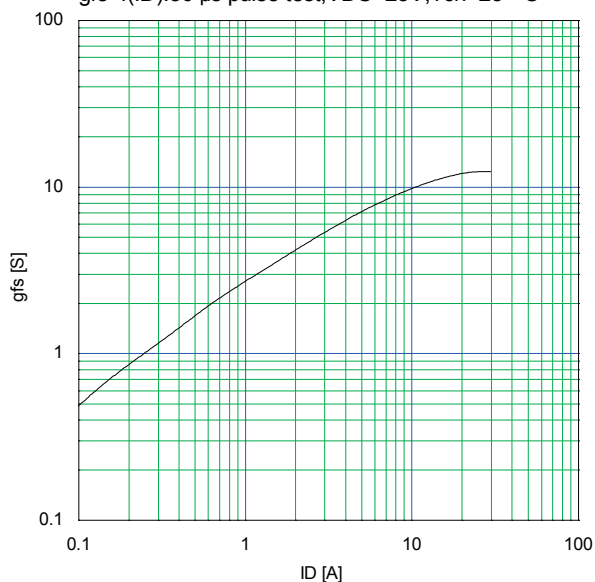
Typical Output Characteristics
 $I_D = f(V_{DS})$: 80 μs pulse test, $T_{ch} = 25$ °C



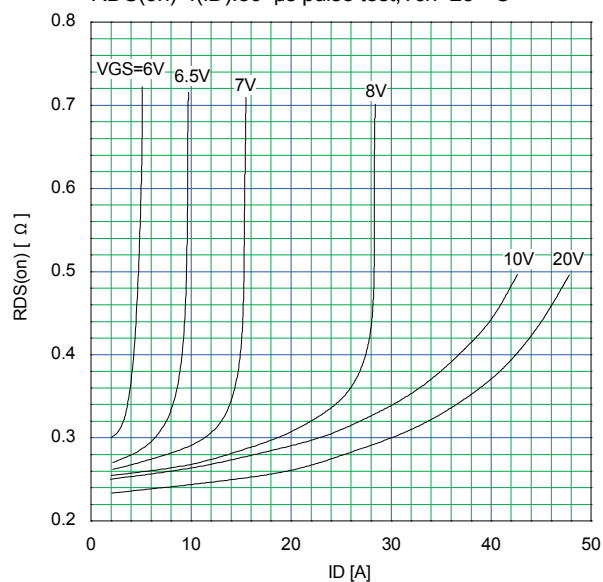
Typical Transfer Characteristic
 $I_D = f(V_{GS})$: 80 μs pulse test, $V_{DS} = 25$ V, $T_{ch} = 25$ °C



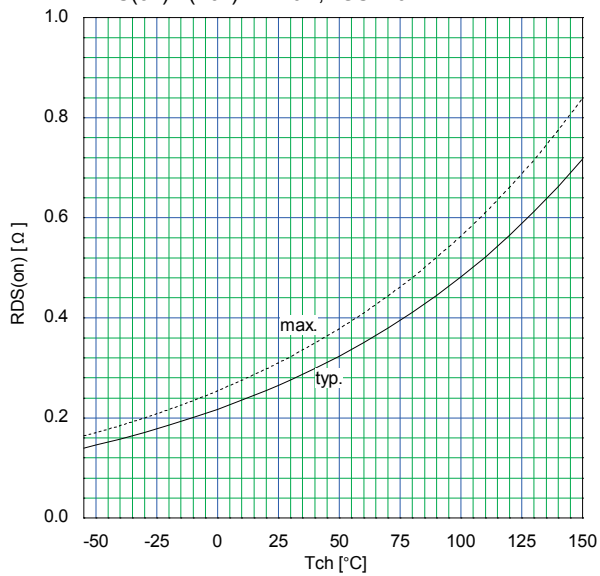
Typical Transconductance
 $g_{fs} = f(I_D)$: 80 μs pulse test, $V_{DS} = 25$ V, $T_{ch} = 25$ °C



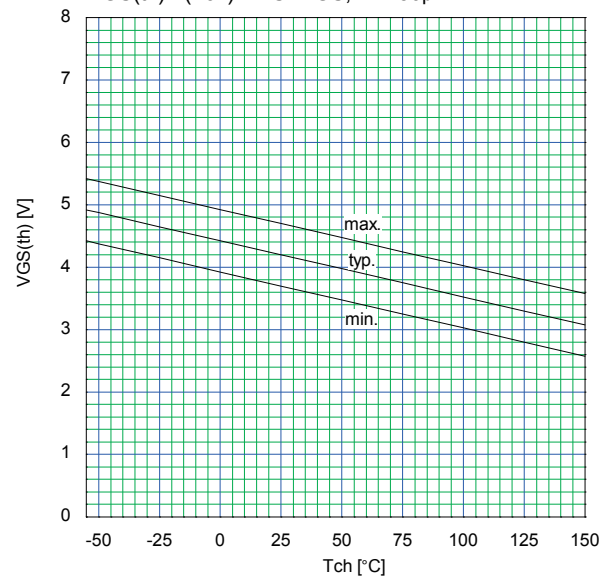
Typical Drain-Source on-state Resistance
 $R_{DS(on)} = f(I_D)$: 80 μs pulse test, $T_{ch} = 25$ °C



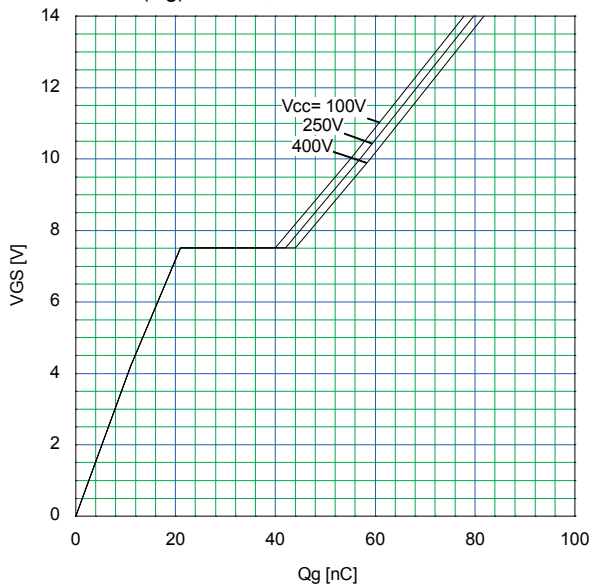
Drain-Source On-state Resistance
 $R_{DS(on)} = f(T_{ch}): I_D = 10A, V_{GS} = 10V$



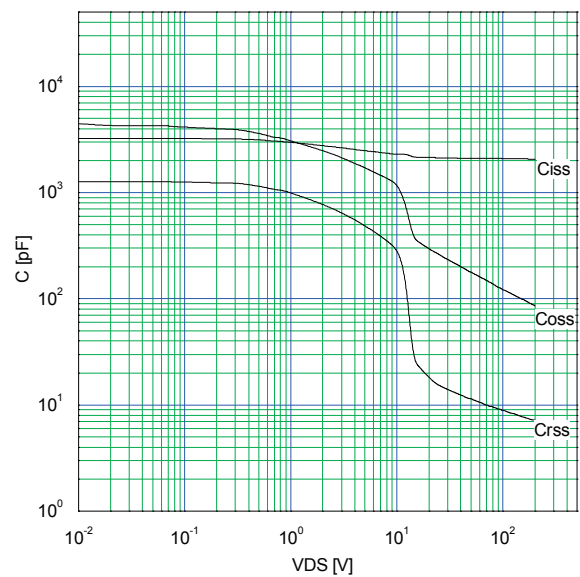
Gate Threshold Voltage vs. T_{ch}
 $V_{GS(th)} = f(T_{ch}): V_{DS} = V_{GS}, I_D = 250\mu A$



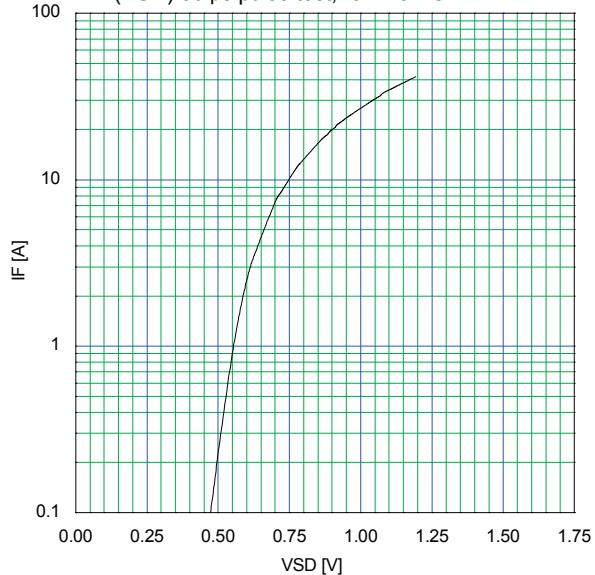
Typical Gate Charge Characteristics
 $V_{GS} = f(Q_g): I_D = 20A, T_{ch} = 25^{\circ}C$



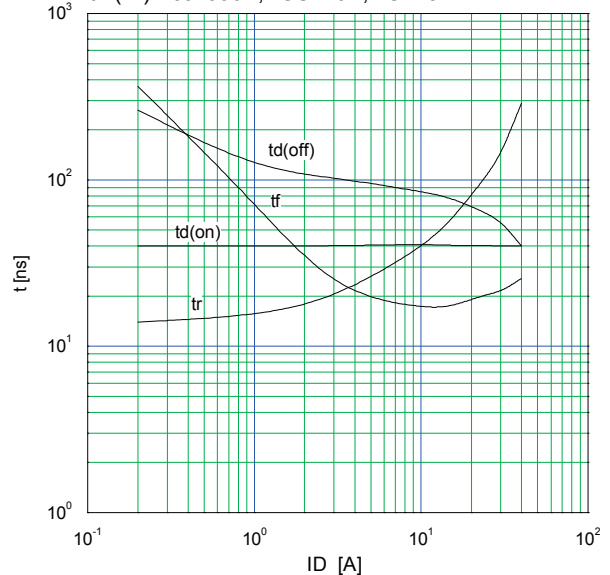
Typical Capacitance
 $C = f(V_{DS}): V_{GS} = 0V, f = 1MHz$

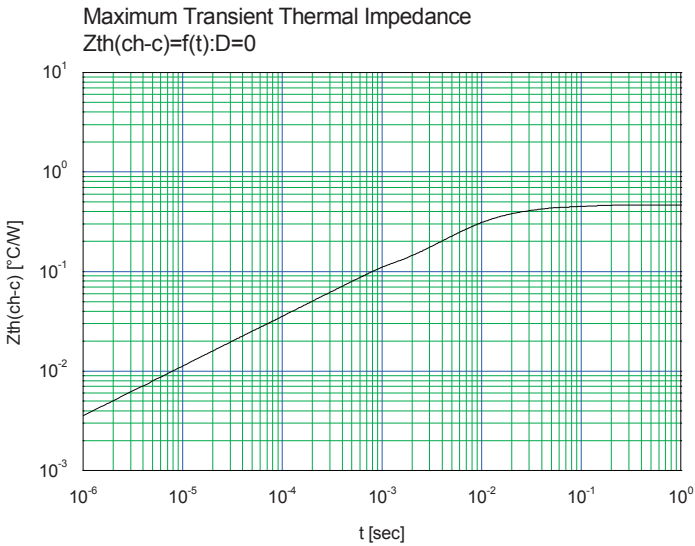
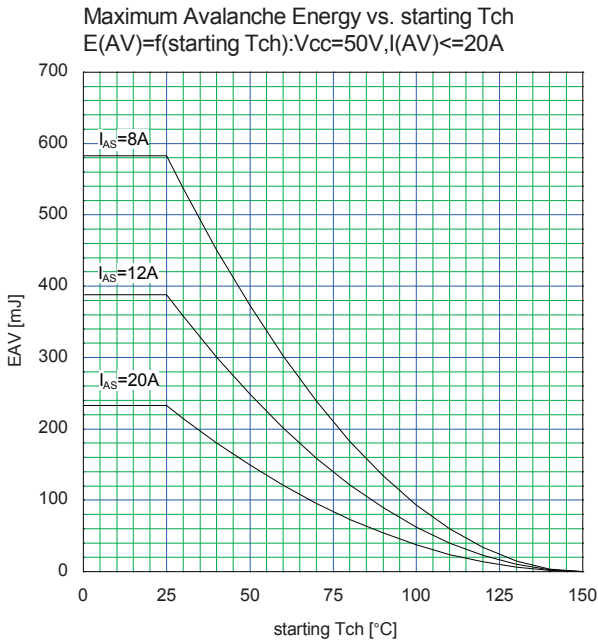


Typical Forward Characteristics of Reverse Diode
 $I_F = f(V_{SD}): 80\mu s$ pulse test, $T_{ch} = 25^{\circ}C$



Typical Switching Characteristics vs. I_D
 $t = f(I_D): V_{CC} = 300V, V_{GS} = 10V, R_G = 15\Omega$





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